

**PbFreeProduct** 

NCE40TD120LT

# 1200V, 40A, Trench FS II Fast IGBT

#### **General Description:**

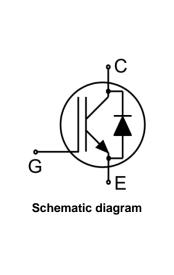
Using NCE's proprietary trench design and advanced FS (Field Stop) second generation technology, the 1200V Trench FSII IGBT offers superior conduction and switching performances, and easy parallel operation;

#### Features

- Trench FSII Technology Offering
- Very low V<sub>CE(sat)</sub>
- High speed switching
- Positive temperature coefficient in V<sub>CE(sat)</sub>
- Very tight parameter distribution
- High ruggedness, temperature stable behavior

#### Application

- Inductive Cooking
- Soft Switching Applications



## Package Marking and Ordering Information

Device	Device Package	Device Marking		
NCE40TD120LT	TO-247	NCE40TD120LT		



TO-247

### Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Value	Units
VCES	Collector-Emitter Voltage	1200	V
$V_{GES}$	Gate- Emitter Voltage	±30	V
L.	Collector Current	80	А
lc	Collector Current @Tc = 100 °C	40	А
I <sub>Cpuls</sub>	Pulsed Collector Current, $t_p$ limited by $T_{jmax}$	120	А
-	turn off safe operating area, $V_{CE}$ =1200V, Tj=150°C	120	А
IF	Diode Continuous Forward Current @Tc = 100 °C	40	А
IFM	Diode Maximum Forward Current	120	А
Power Dissipation @ $T_c = 25^{\circ}C$		468	W
PD	Power Dissipation @T <sub>C</sub> = 100 °C	234	W
TJ,Tstg	Operating Junction and Storage Temperature Range	-55 to +175	°C
ΤL	Maximum Temperature for Soldering	260	°C



## **Thermal Characteristic**

Symbol	Parameter	Value	Units
Rejc	Thermal Resistance, Junction to case for IGBT	0.32	°C/W
Rejc	Thermal Resistance, Junction to case for Diode	0.86	°C/W
Reja	Thermal Resistance, Junction to Ambient	40	°C/W

# Electrical Characteristics (Tc=25°C unless otherwise noted)

Cumb c l	Demonster	Test Conditions		Value			
Symbol	Parameter			Min.	Тур.	Max.	Units
Static Chara	cteristics						
V <sub>(BR)CES</sub>	Collector-Emitter Breakdown Voltage	V <sub>GE</sub> =0V	,I <sub>CE</sub> =1mA	1200			V
ICES	Collector-Emitter Leakage Current	V <sub>GE</sub> =0V,	V <sub>CE</sub> =1200V			5	uA
IGES(F)	Gate to Emitter Forward Leakage	V <sub>GE</sub> =+30	V,V <sub>CE</sub> =0V			200	nA
IGES(R)	Gate to Source Reverse Leakage	V <sub>GE</sub> =-30V,V <sub>CE</sub> =0V				200	nA
M		Ic=40A	Tj=25°C		1.50	1.75	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$V_{GE}=15V$	Tj=150°C		1.9		V
$V_{\text{GE(th)}}$	Gate Threshold Voltage	Ic=1mA,VcE=VGE		5.0		6.5	V
Dynamic Ch	aracteristics	-				· · ·	
Cies	Input Capacitance				5590		pF
Coes	Output Capacitance				177		
Cres	Reverse Transfer Capacitance				134		
Qg	Total Gate Charge	Vcc=960V, Ic=40A, V <sub>GE</sub> =15V			298		nC
Q <sub>ge</sub>	Gate to Emitter Charge				52		
Q <sub>gc</sub>	Gate to Collector Charge				169		
Switching Cl	haracteristics	-					
t <sub>d(ON)</sub>	Turn-on Delay Time				19		
tr	Rise Time				17		
$t_{\text{d}(\text{OFF})}$	Turn-Off Delay Time	$V_{CE}=600V,I_C=40A,$ $V_{GE}=0/15V, R_g=8\Omega$ Inductive Load			170		ns
t <sub>f</sub>	Fall Time				18		
Eon	Turn-On Switching Loss				2.4		
E <sub>off</sub>	Turn-Off Switching Loss				1.8		mJ
Ets	Total Switching Loss				4.2		

# Electrical Characteristics of the Diode(T<sub>C</sub>= 25°C unless otherwise specified):

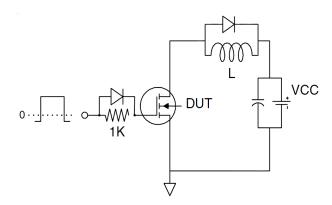
Symbol	Parameter	Test Conditions	Rating			Unito
			Min.	Тур.	Max.	Units
Vfm	Diode Forward Voltage	IF=20A		2.5	3.4	V
Trr	Reverse Recovery Time	1 204		120		ns
IRRM	Diode Peak Reverse Recovery Current	IF=20A,		12		А
Qrr	Reverse Recovery Charge	di/dt=200A/us		0.72		uC
Pulse width t <sub>tp</sub> ≤380μs,δ≤2%						



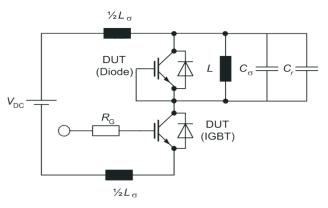


## **Test Circuit**

## 1) Gate Charge Test Circuit

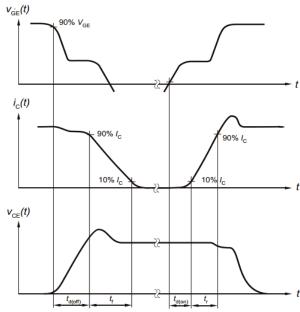


## 2) Switch Time Test Circuit

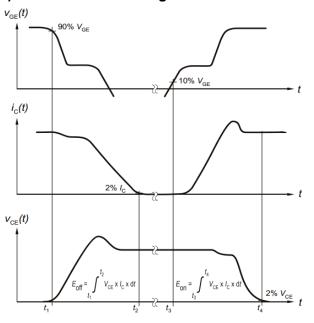


## Switching characteristics

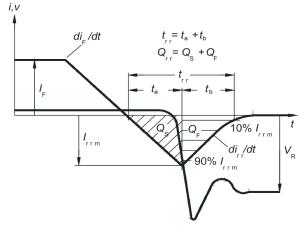
1) Definition of switching times



# 2) Definition of switching losses

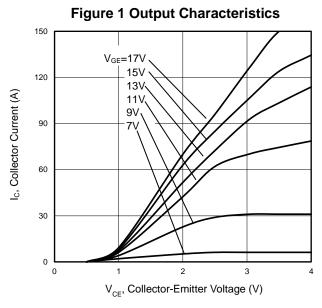


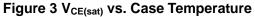
## 3) Definition of diode switching characteristics

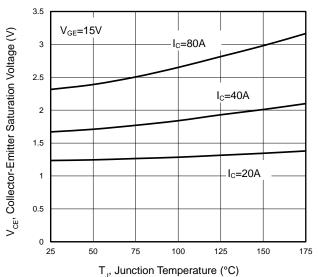


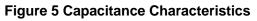


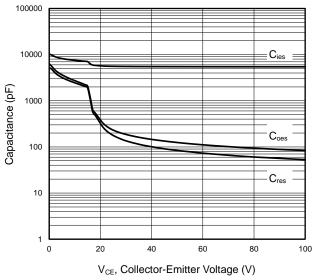
# **Typical Electrical and Thermal Characteristics**

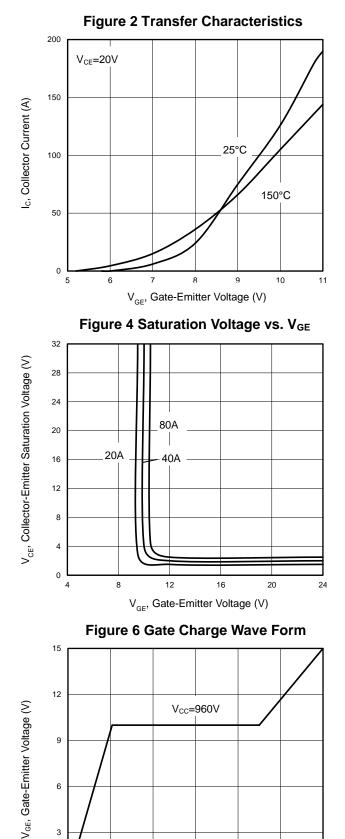












100

150

Q<sub>G</sub>, Total Gate Charge (nC)

200

250

50

3

0

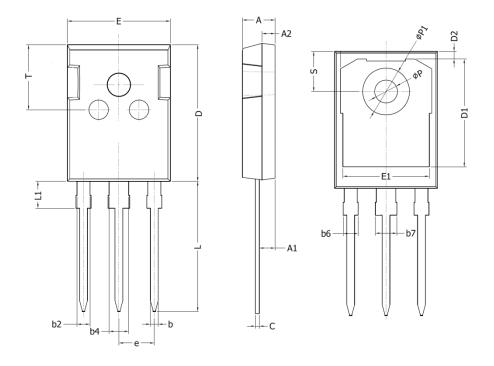
0

300



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# **TO-247 Package Information**



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	4.90	5.10	0.193	0.201	
A1	2.31	2.51	0.091	0.099	
A2	1.9	2.1	0.075	0.083	
b	1.16	1.26	0.046	0.050	
b2	1.96	2.06	0.077	0.081	
b4	2.96	3.06	0.117	0.120	
b6	-	2.25	-	0.089	
b7	-	3.25	-	0.128	
С	0.59	0.66	0.023	0.026	
D	20.90	21.10	0.823	0.831	
D1	16.25	16.85	0.640	0.663	
D2	1.05	1.35	0.041	0.053	
E	15.70	15.90	0.618	0.626	
E1	13.10	13.50	0.516	0.531	
е	5.436	0.214 BSC 0.214 BSC		С	
L	19.80	20.10	0.780	0.791	
L1	-	4.30	-	0.169	
Р	3.40	3.60	0.134	0.142	
P1	7.00	7.40	0.276 0.29		
S	6.05	6.25	0.238	0.246	
Т	9.80	10.20	0.386 0.402		



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